
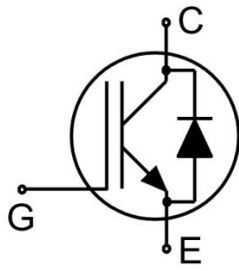


650V, 75A, Trench FS IGBT

1. Descriptions

| |
|--|
| TO-247 |
|  <p style="text-align: center; margin-top: 5px;">G C E</p> |
| Schematic diagram |
|  |

Key Performance Parameters

| Parameters | Value | Unit |
|--------------------------------|-------|------|
| V_{CE} | 650 | V |
| I_c | 75 | A |
| $V_{CE(sat), T_J=25^{\circ}C}$ | 1.72 | V |

Features

- Trench FS Technology offering.
- Very low $V_{CE(sat)}$.
- Positive temperature coefficient in $V_{CE(sat)}$.
- Very tight parameter distribution.
- High ruggedness, temperature stable behavior.
- Maximum Junction Temperature: $T_J=175^{\circ}C$.

Applications

- PFC.
- Solar Converters.
- Uninterruptible Power Suppliers.
- Welding Converters.
- Mid to High Range Switching Frequency Converters.

| Type/Ordering Code | Package | Marking | Related Links |
|--------------------|---------|----------|----------------|
| FKW75N65F2J | TO-247 | 75N65F2J | see Appendix A |



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2. Maximum ratings

at $T_j = 25^\circ\text{C}$, Unless Otherwise Specified

Table 1. Absolute Maximum Ratings

| Symbol | Parameter | Values | Unit | Test Condition |
|----------------|---|----------------------|------------------|---|
| V_{CES} | Collector-Emitter Voltage | 650 | V | $V_{GS}=0V$ |
| V_{GES} | Gate- Emitter Voltage Transient Gate-Emitter Voltage ($t_p \leq 10\mu s, D < 0.010$) | ± 20 ± 30 | V | |
| I_C | Collector Current | 150 75 | A | $T_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$ |
| $I_{C,pulse}$ | Pulsed Collector Current , t_p limited by T_{jmax} | 300 | A | |
| - | turn off safe operating area | 300 | A | $V_{CE}=650V, T_j=150^\circ\text{C}$ |
| I_F | Diode Continuous Forward Current | 75 | A | $T_C=100^\circ\text{C}$ |
| I_{FM} | Diode Maximum Forward Current | 300 | A | |
| P_D | Power Dissipation | 395 | W | $T_C=25^\circ\text{C}$ |
| | | 197 | W | $T_C=100^\circ\text{C}$ |
| T_J, T_{stg} | Operating Junction and Storage Temperature Range | -55~175 | $^\circ\text{C}$ | |
| T_L | Maximum Temperature for Soldering | 260 | $^\circ\text{C}$ | |

3. Thermal characteristics

Table 2. Thermal Characteristics

| Symbol | Parameter | Values | | | Unit | Test Condition |
|-------------|--|--------|------|------|---------------------------|--------------------------|
| | | Min. | Typ. | Max. | | |
| R_{thJC} | Thermal resistance, Junction to case for IGBT | | | 0.38 | $^\circ\text{C}/\text{W}$ | $T_C = 25^\circ\text{C}$ |
| R_{thJCD} | Thermal resistance, Junction to case for Diode | | | 0.22 | $^\circ\text{C}/\text{W}$ | $T_C = 25^\circ\text{C}$ |
| R_{thJA} | Thermal resistance, Junction to Ambient | | | 40 | $^\circ\text{C}/\text{W}$ | $T_C = 25^\circ\text{C}$ |



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4. Electrical characteristics

at $T_j = 25^\circ\text{C}$, Unless Otherwise Specified

Table 3. Static Characteristics

| Symbol | Parameter | Values | | | Unit | Test Condition |
|---------------|--------------------------------------|--------|------|-----------|---------|--|
| | | Min. | Typ. | Max. | | |
| $V_{(BR)CES}$ | Collector-Emitter Breakdown Voltage | 650 | | | V | $V_{GE}=0V, I_{CE}=1mA$ |
| I_{CES} | Collector-Emitter Leakage Current | | | 5 | μA | $V_{GE}=0V, V_{CE}=650V$ |
| I_{GES} | Gate to Emitter leakage current | | | ± 200 | nA | $V_{GE}=\pm 30V, V_{CE}=0V$ |
| $V_{CE(sat)}$ | Collector-Emitter Saturation Voltage | | 1.72 | 2.0 | V | $V_{GE}=15V, I_C=75A, T_j=25^\circ C$ |
| | | | 2.22 | 2.5 | V | $V_{GE}=15V, I_C=75A, T_j=175^\circ C$ |
| V_{FM} | Diode forward voltage | | 1.07 | | V | $I_F=75A, T_f=25^\circ C$ |
| | | | 0.96 | | V | $I_F=75A, T_f=175^\circ C$ |
| $V_{GE(th)}$ | Gate Threshold Voltage | 3 | 3.8 | 5 | V | $I_C=1mA, V_{CE}=V_{GE}$ |

Table 4. Dynamic Characteristics

| Symbol | Parameter | Values | | | Unit | Test Condition |
|-----------|------------------------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| C_{ies} | Input capacitance | | 3327 | | pF | $V_{GE}=0V, V_{CE}=25V, f=1MHz$ |
| C_{oes} | Output capacitance | | 280 | | pF | $V_{GE}=0V, V_{CE}=25V, f=1MHz$ |
| C_{res} | Reverse transfer capacitance | | 40 | | pF | $V_{GE}=0V, V_{CE}=25V, f=1MHz$ |
| Q_g | Total Gate Charge | | 134 | | nC | $V_{CC}=480V, I_C=75A, V_{GE}=0 \text{ to } 15V$ |
| Q_{ge} | Gate to Emitter Charge | | 25 | | nC | |
| Q_{gc} | Gate to Collector Charge | | 52 | | nC | |

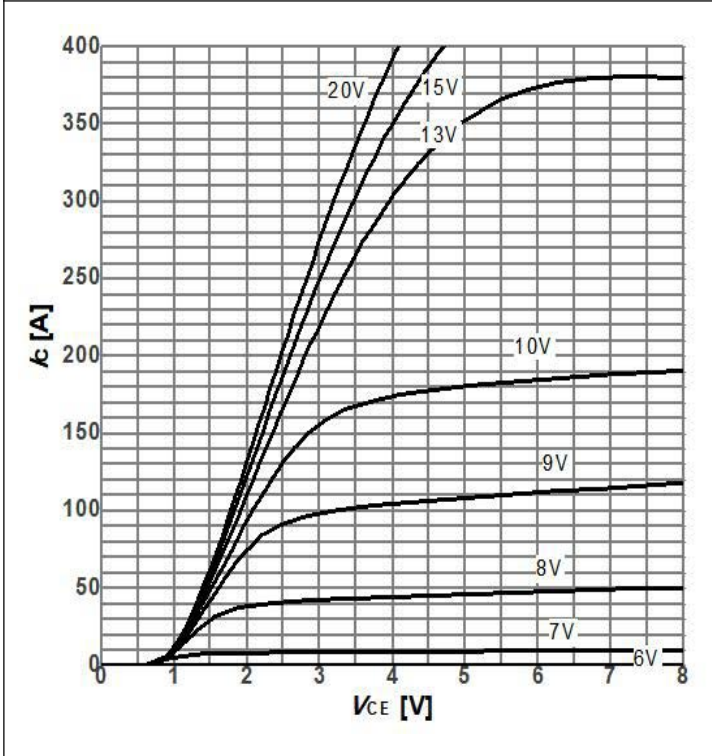
Table 5. Switching Characteristics

| Symbol | Parameter | Values | | | Unit | Test Condition |
|--------------|-------------------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| $t_{d(on)}$ | Turn-on delay time | | 37 | | ns | $V_{CE}=400V, I_C=75A, V_{GE}=15V, R_g=10\Omega, \text{ Inductive Load}$ |
| t_r | Rise time | | 38 | | ns | |
| $t_{d(off)}$ | Turn-off delay time | | 208 | | ns | |
| t_f | Fall time | | 87 | | ns | |
| E_{on} | Turn-On Switching Loss | | 1.68 | | mJ | |
| E_{off} | Turn-Off Switching Loss | | 1.54 | | mJ | |
| E_{ts} | Total Switching Loss | | 3.22 | | mJ | |

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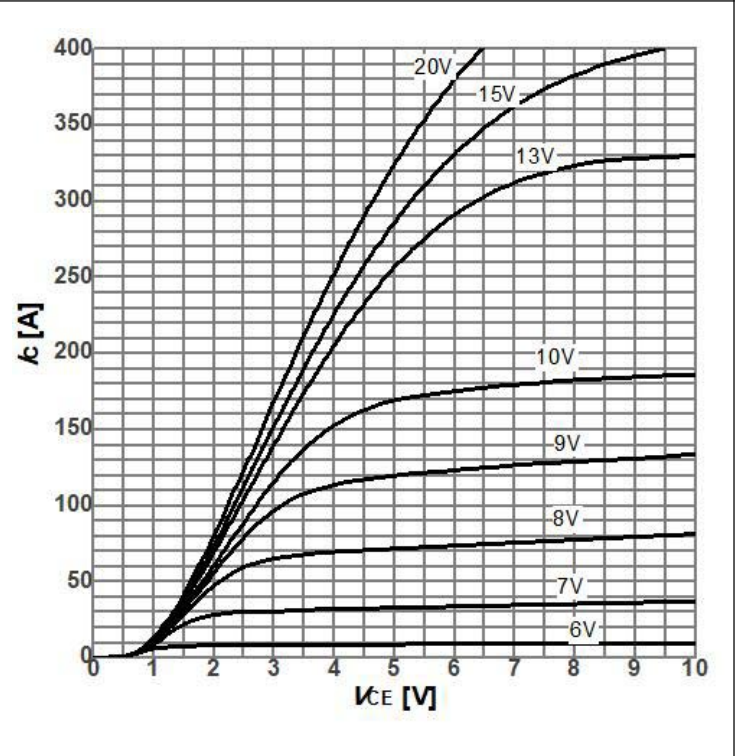
5. Electrical characteristics diagrams

Diagram 1: Typ. output characteristics



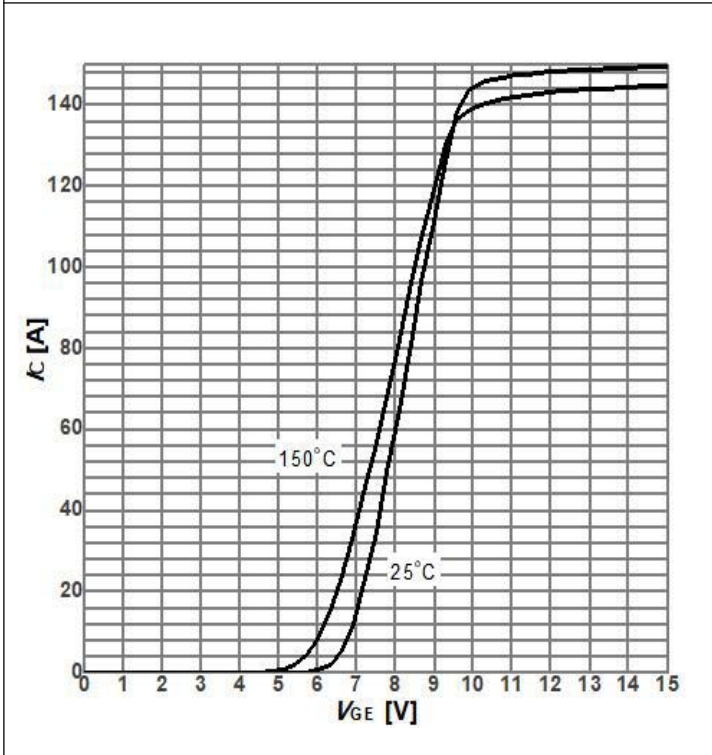
$I_C = f(V_{CE}); T_J = 25^\circ\text{C};$ parameter: V_{GE}

Diagram 2: Typ. output characteristics



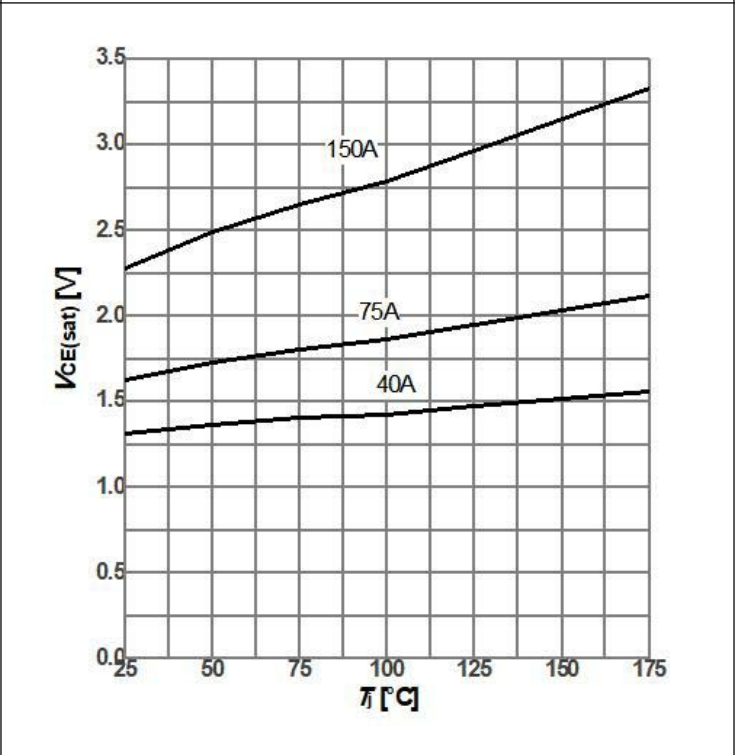
$I_C = f(V_{CE}); T_J = 150^\circ\text{C};$ parameter: V_{GE}

Diagram 3: Typ. transfer characteristics



$I_C = f(V_{GE}); V_{CE} = 20\text{V};$ parameter: T_J

Diagram 4: $V_{CE(sat)}$ vs. Case Temperature



$V_{CE(sat)} = f(T_J); V_{GE} = 15\text{V};$ parameter: I_C

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Diagram 5: $V_{GE(th)}$ vs. Case Temperature

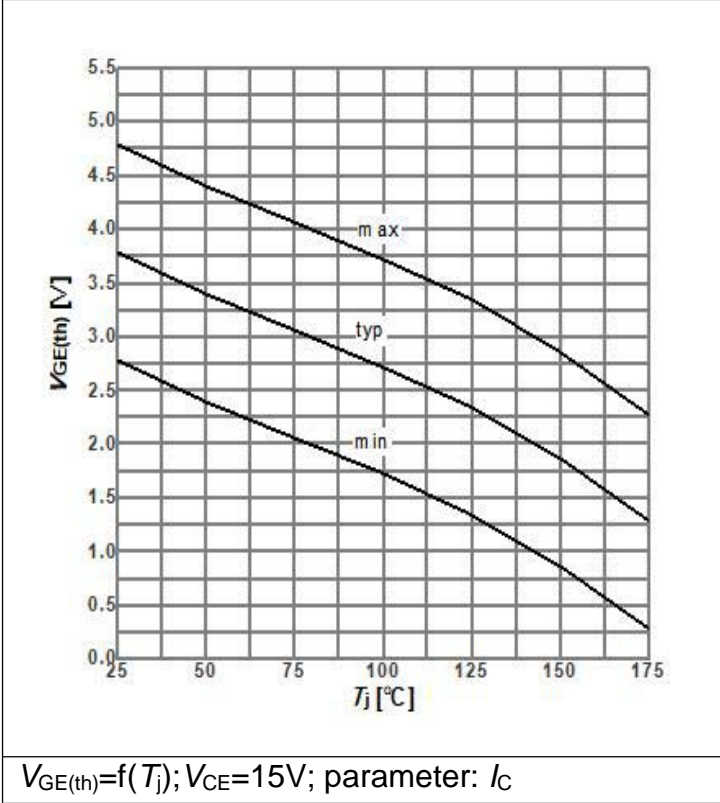


Diagram 6: Saturation Voltage vs. V_{GE}

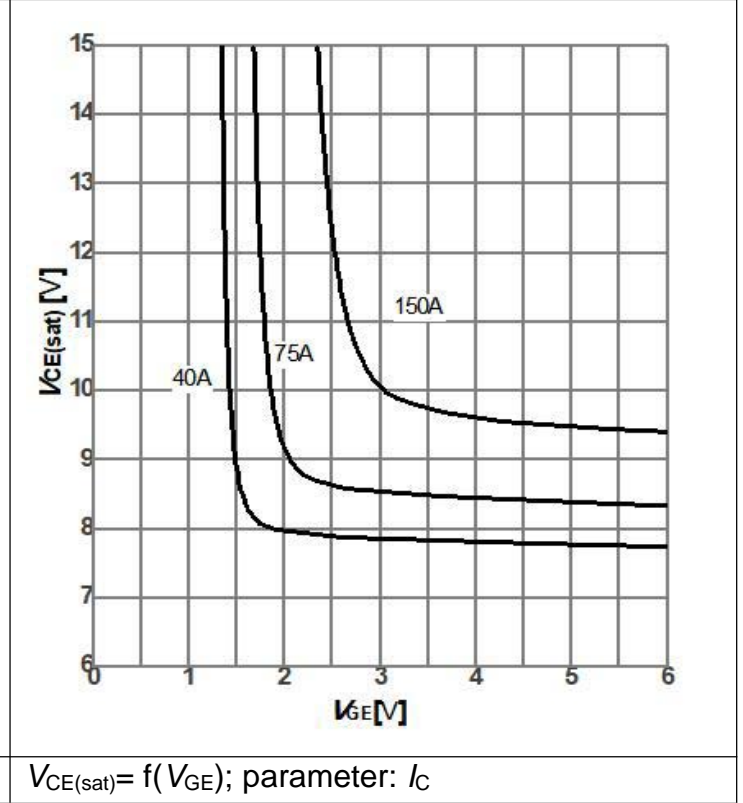


Diagram 7: Typ. capacitances

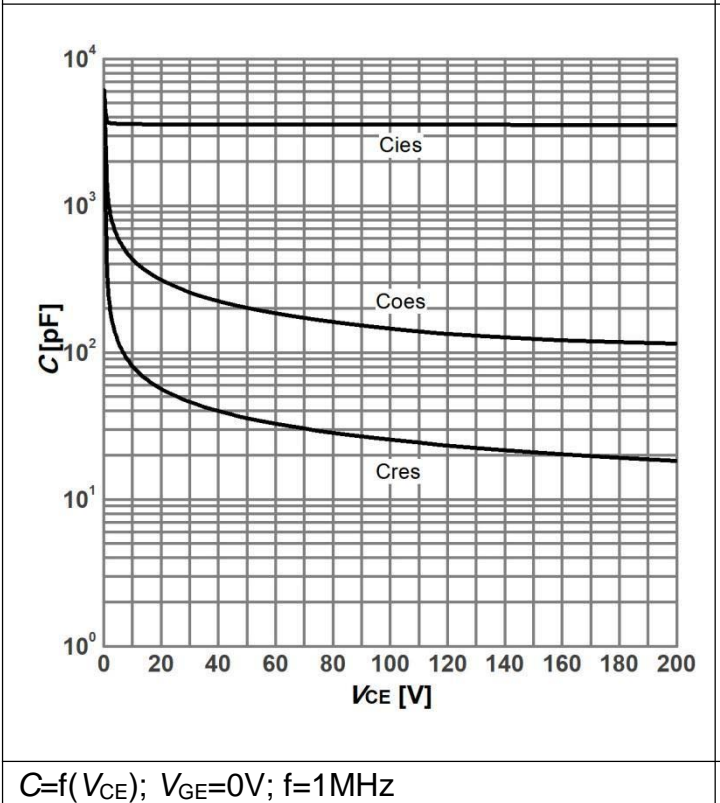
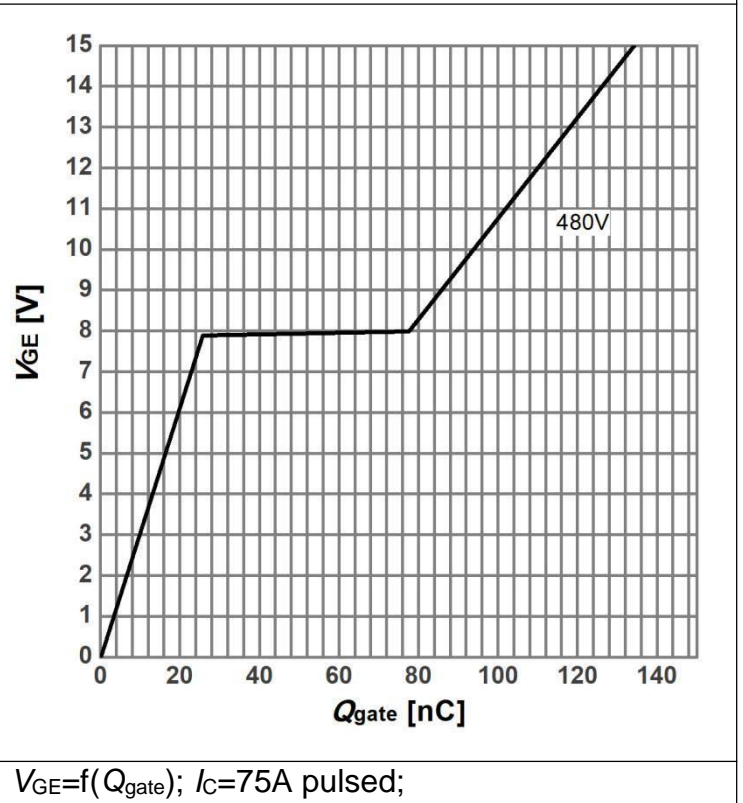
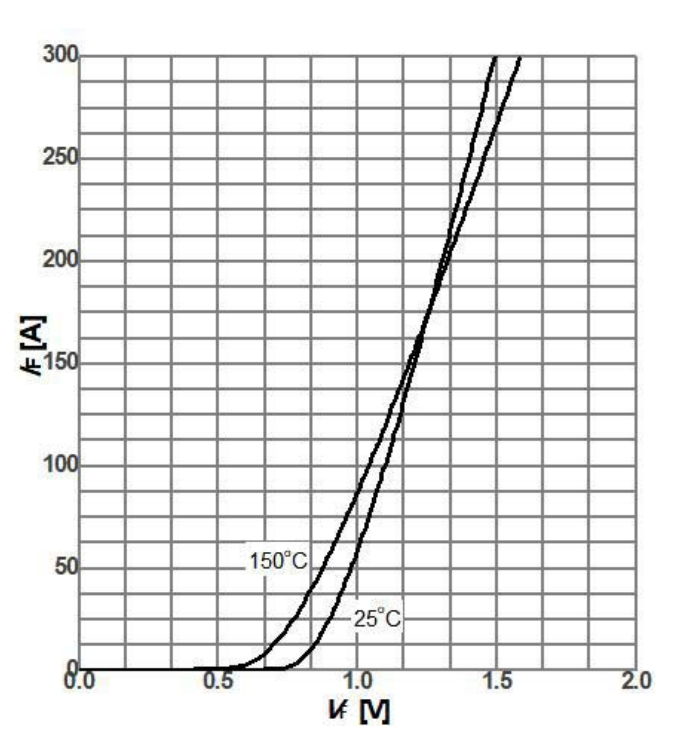


Diagram 8: Typ. gate charge



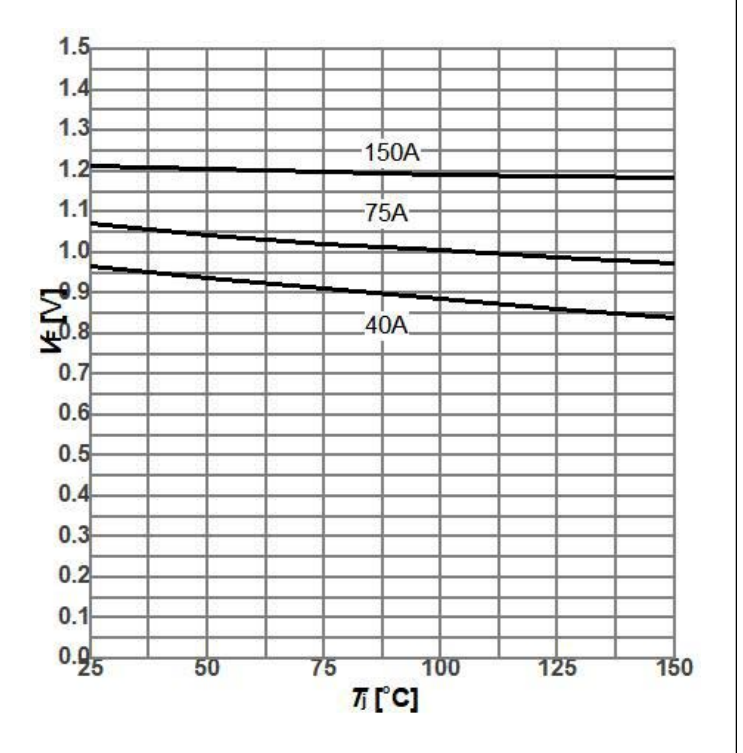
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Diagram 9: Typ. Diode forward current as a function of forward voltage



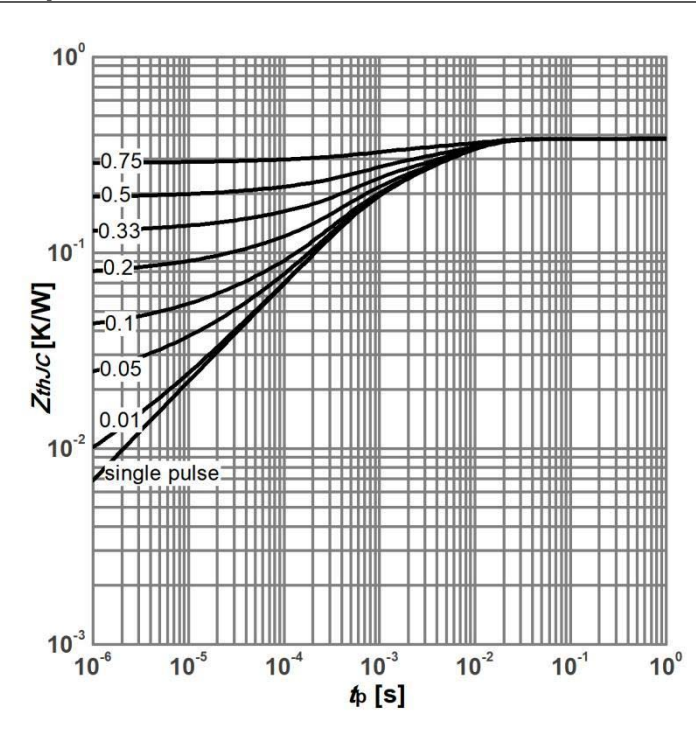
$I_F=f(V_F)$; parameter: T_j

Diagram 10: Typ. Diode forward voltage as a function of junction temperature



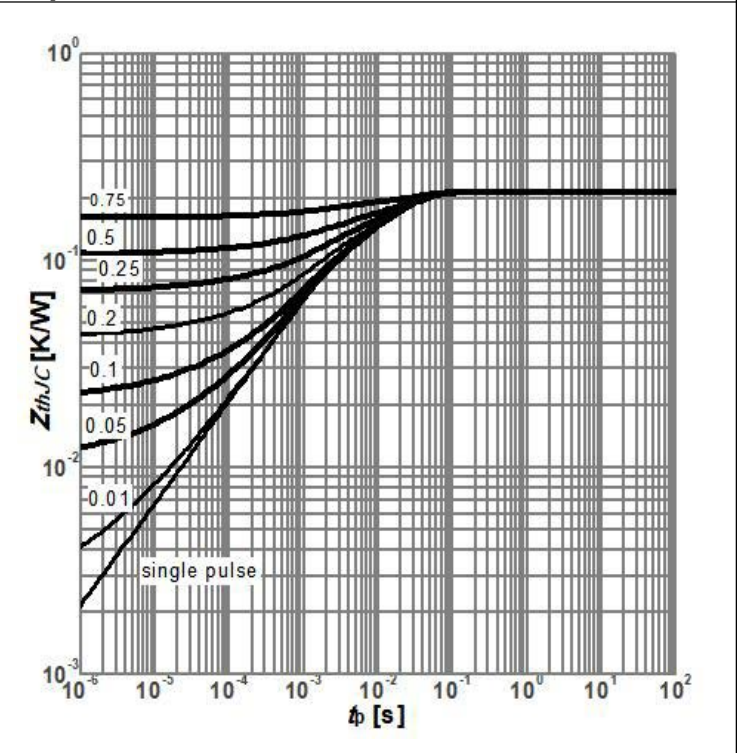
$V_F=f(T_j)$; parameter: I_C

Diagram 11: Max. IGBT transient thermal impedance



$Z_{thJC}=f(t_p)$; parameter: $D=t_p/T$

Diagram 12: Max. Diode transient thermal impedance



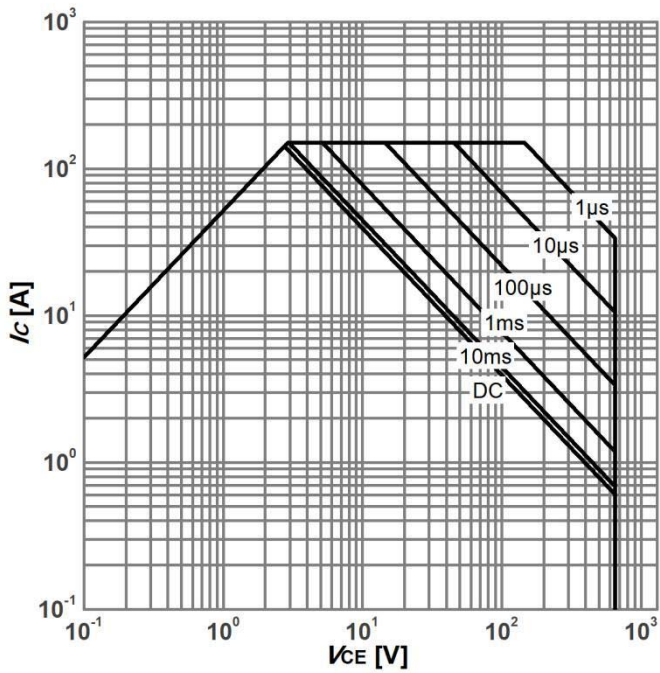
$Z_{thJC}=f(t_p)$; parameter: $D=t_p/T$



FKW75N65F2J

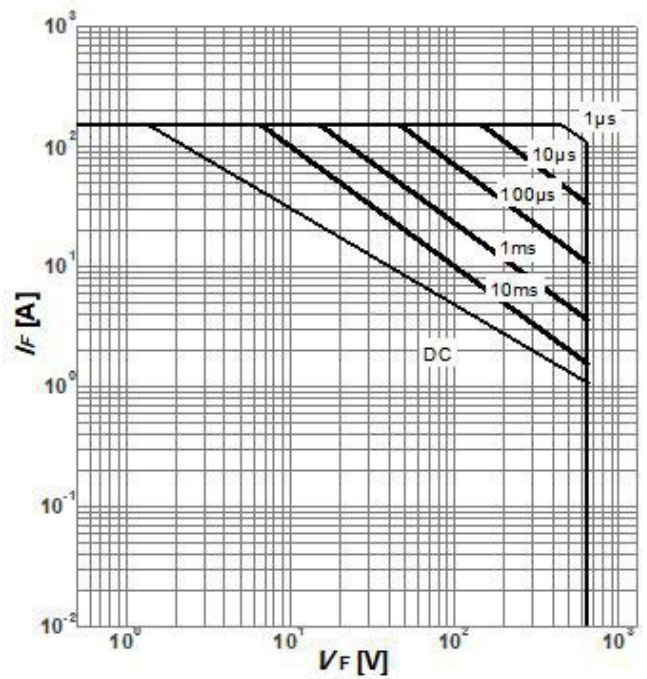
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Diagram 13: IGBT Safe operating area



$Z_{thJC}=f(t_p)$; parameter: $D= t_p/T$

Diagram 14: Diode Safe operating area



$Z_{thJC}=f(t_p)$; parameter: $D= t_p/T$

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6. Test Circuits

Table 7. Test Circuit

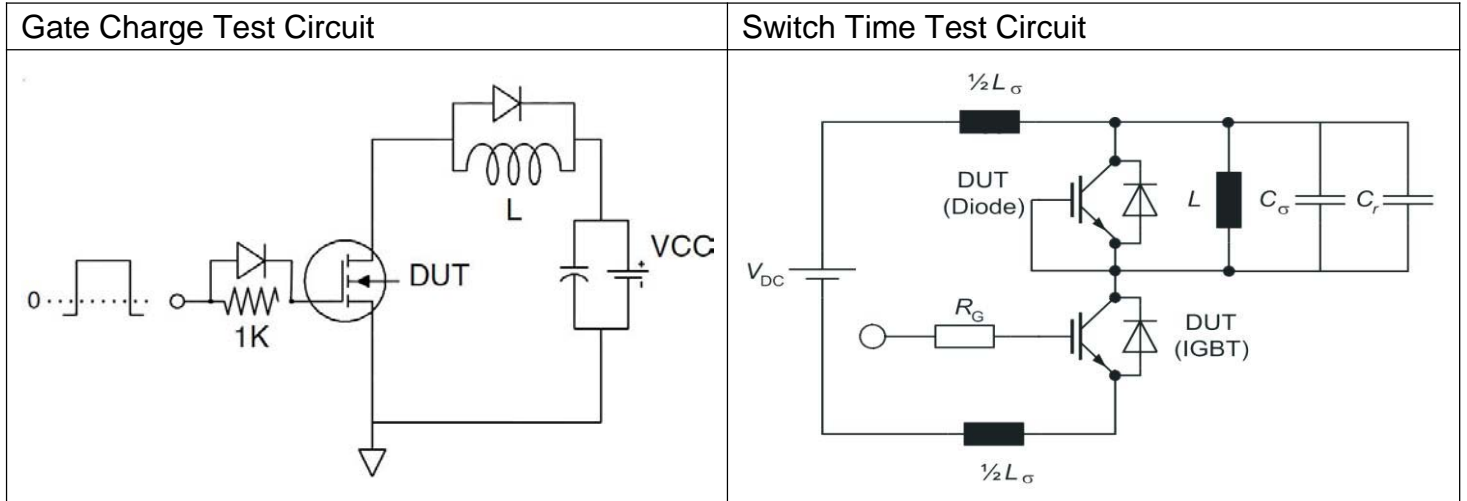
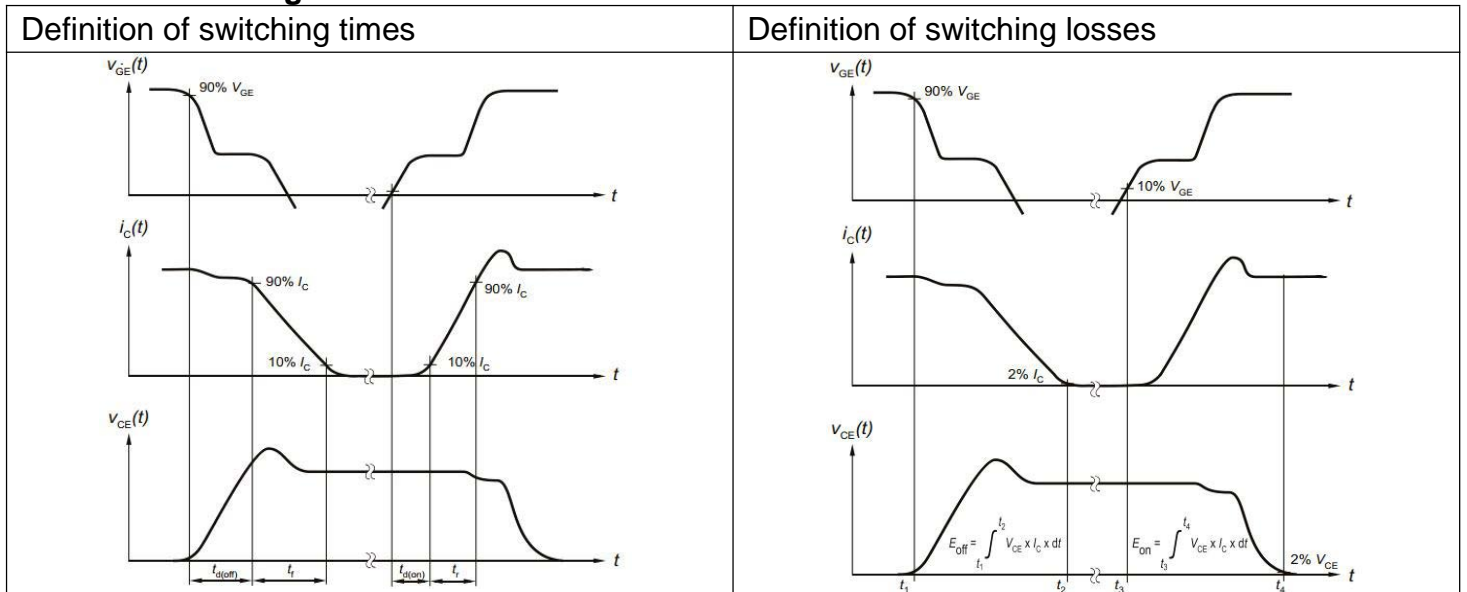
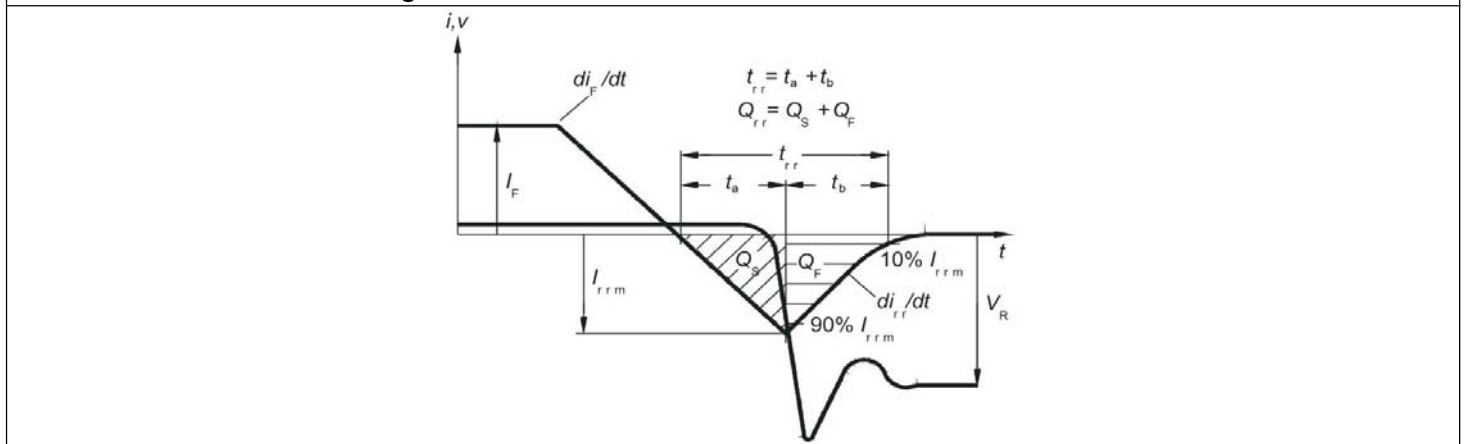


Table 8. Switching characteristics



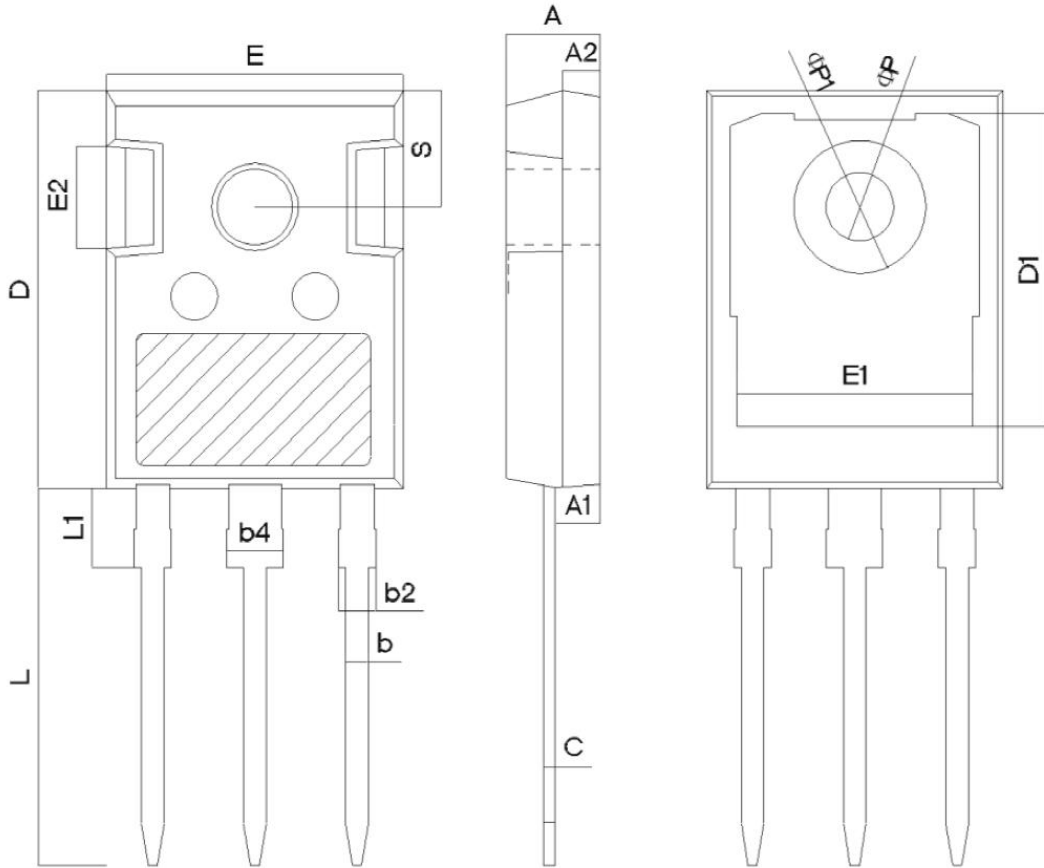
Definition of diode switching characteristics



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7. Package Outlines

Figure 1 Outline TO-247 dimensions in mm



| SYMBOL | mm | | |
|--------|---------|-------|-------|
| | MIN | NOM | MAX |
| A | 4.80 | 5.00 | 5.20 |
| A1 | 2.21 | 2.41 | 2.61 |
| A2 | 1.85 | 2.00 | 2.15 |
| b | 1.11 | 1.21 | 1.36 |
| b2 | 1.91 | 2.01 | 2.21 |
| b4 | 2.91 | 3.01 | 3.21 |
| c | 0.51 | 0.61 | 0.75 |
| D | 20.70 | 21.00 | 21.30 |
| D1 | 16.25 | 16.55 | 16.85 |
| E | 15.50 | 15.80 | 16.10 |
| E1 | 13.00 | 13.30 | 13.60 |
| E2 | 4.80 | 5.00 | 5.20 |
| E3 | 2.30 | 2.50 | 2.70 |
| e | 5.44BSC | | |
| L | 19.62 | 19.92 | 20.22 |
| L1 | - | - | 4.30 |
| phiP | 3.40 | 3.60 | 3.80 |
| phiP1 | - | - | 7.30 |
| S | 6.15BSC | | |